

TOSHIBA CMOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

# TC7WH123FU, TC7WH123FK

## MONOSTABLE MULTIVIBRATOR

The TC74WH123 is high speed CMOS MONOSTABLE MULTIVIBRATOR fabricated with silicon gate C<sup>2</sup>MOS technology.

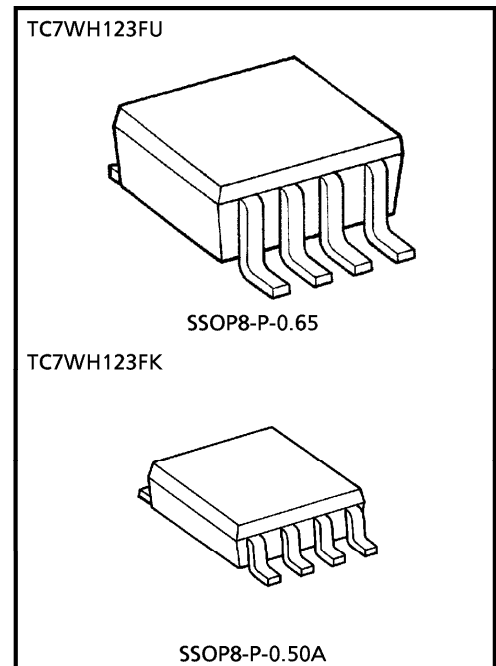
There are two trigger inputs,  $\bar{A}$  input (Negative edge), and B input (Positive edge). These inputs are valid for a slow rise/fall time signal ( $t_r = t_f = 1\text{sec.}$ ) as they are schmitt trigger inputs. This device may also be triggered by using  $\overline{\text{CLR}}$  input (Positive edge).

After triggering, the output stays in a MONOSTABLE state for a time period determined by the external resistor and capacitor ( $R_x, C_x$ ). A low level at the  $\overline{\text{CLR}}$  input breaks this state.

Limits for  $C_x$  and  $R_x$  are :

- External capacitor,  $C_x$  ..... No limit
- External resistor,  $R_x$  .....  $V_{CC} = 2.0\text{V}$  more than  $5\text{k}\Omega$   
 $V_{CC} \geq 3.0\text{V}$  more than  $1\text{k}\Omega$

An input protection circuit ensures that 0 to 7V can be applied to the input pins without regard to the supply voltage. This device can be used to interface 5V to 3V systems and two supply systems such as battery back up. This circuit prevents device destruction due to mismatched supply and input voltages.

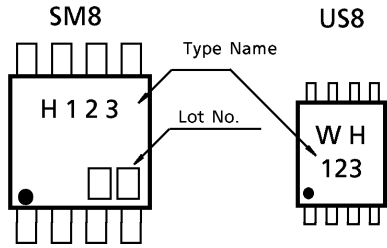


Weight  
 SSOP8-P-0.65 : 0.02g (Typ.)  
 SSOP8-P-0.50A : 0.01g (Typ.)

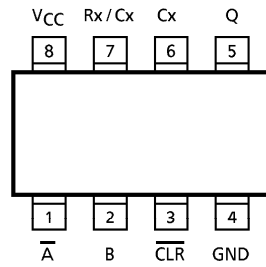
### FEATURES

- High Speed .....  $t_{pd} = 8.1\text{ns}$  (Typ.) at  $V_{CC} = 5\text{V}$
- Low Power Dissipation
  - Standby State .....  $I_{CC} = 2\mu\text{A}$  (Max.) at  $T_a = 25^\circ\text{C}$
  - Active State .....  $I_{CC} = 600\mu\text{A}$  (Max.) at  $V_{CC} = 5\text{V}$
- High Noise Immunity .....  $V_{NIH} = V_{NIL} = 28\% V_{CC}$  (Min.)
- Power Down Protection is provided on all inputs.
- Balanced Propagation Delays .....  $t_{pLH} = t_{pHL}$
- Wide Operation Voltage Range ...  $V_{CC}(\text{opr}) = 2 \sim 5.5\text{V}$

**MARKING**



**PIN ASSIGNMENT (TOP VIEW)**

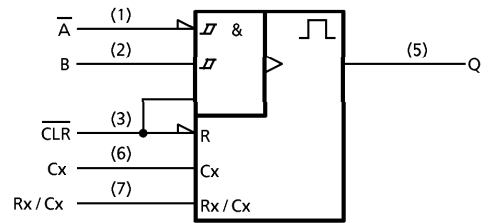


**TRUTH TABLE**

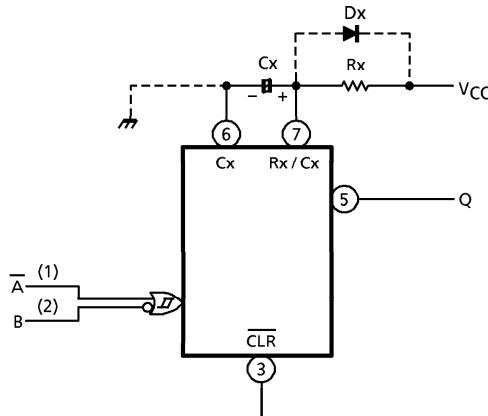
INPUTS			OUTPUTS	NOTE
$\bar{A}$	B	$\bar{CLR}$	Q	
$\downarrow$	H	H	$\square$	OUTPUT ENABLE
x	L	H	L	INHIBIT
H	x	H	L	INHIBIT
L	$\uparrow$	H	$\square$	OUTPUT ENABLE
L	H	$\uparrow$	$\square$	OUTPUT ENABLE
x	x	L	L	RESET

x : Don't Care

**LOGIC DIAGRAM**



**BLOCK DIAGRAM**



(Note 1) Cx, Rx, Dx are external

Capacitor, Resistor, and Diode, respectively.

(Note 2) External clamping diode, Dx ;

The external capacitor is charged to  $V_{CC}$  level in the wait state, i.e. when no trigger is applied.

If the supply voltage is turned off, Cx is discharges mainly through the internal (parasitic) diode. If Cx is sufficiently large and  $V_{CC}$  drops rapidly, there will be some possibility of damaging the IC through inrush current or latch-up. If the capacitance of the supply voltage filter is large enough and  $V_{CC}$  drops slowly, the inrush current is automatically limited and damage to the IC is avoided.

The maximum value of forward current through the parasitic diode is  $\pm 20\text{mA}$ .

In the case of a large Cx, the limit of fall time of the supply voltage is determined as follows:

$$t_r \geq (V_{CC} - 0.7) \cdot C_x / 20\text{mA}$$

( $t_r$  is the time between the supply voltage turn off and the supply voltage reaching 0.4  $V_{CC}$ .)

In the even a system does not satisfy the above condition, an external clamping diode (Dx) is needed to protect the IC from inrush current.

## FUNCTIONAL DESCRIPTION

### (1) Stand-by State

The external capacitor (Cx) is fully charged to  $V_{CC}$  in the stand-by state. That means, before triggering, the  $Q_P$  and  $Q_N$  transistors which are connected to the Rx/Cx node are in the off state. Two comparators that relate to the timing of the output pulse, and two reference voltage supplies turn off. The total supply current is only leakage current.

### (2) Trigger operation

Trigger operation is effective in any of the following three cases. First, the condition where the  $\bar{A}$  input is low, and the B input has a rising signal ; second, where the B input is high, and the  $\bar{A}$  input has a falling signal ; and third, where the  $\bar{A}$  input is low and the B input is high, and the  $\bar{CLR}$  input has a rising signal.

After a trigger becomes effective, comparators C1 and C2 start operating, and  $Q_N$  is turned on. The external capacitor discharges through  $Q_N$ . The voltage level at the Rx/Cx node drops. If the Rx/Cx voltage level falls to the internal reference voltage  $V_{refL}$ , the output of C1 becomes low. The flip-flop is then reset and  $Q_N$  turns off. At that moment C1 stops but C2 continues operating.

After  $Q_N$  turns off, the voltage at the Rx/Cx node starts rising at a rate determined by the time constant of external capacitor Cx and resistor Rx.

Upon triggering, output Q becomes high, following some delay time of the internal F/F and gates. It stays high even if the voltage of Rx/Cx changes from falling to rising. When Rx/Cx reaches the internal reference voltage  $V_{refH}$ , the output of C2 becomes low, the output Q goes low and C2 stops its operation. That means, after triggering, when the voltage level of the Rx/Cx node reaches  $V_{refH}$ , the IC returns to its MONOSTABLE state.

With large values of Cx and Rx, and ignoring the discharge time of the capacitor and internal delays of the IC, the width of the output pulse,  $t_w$  (OUT), is as follows :

$$t_w(\text{OUT}) = 1.0 C_x R_x$$

### (3) Retrigger operation

When a new trigger is applied to either input  $\bar{A}$  or B while in the MONOSTABLE state, it is effective only if the IC is charging Cx. The voltage level of the Rx/Cx node then falls to  $V_{refL}$  level again. Therefore the Q output stays high if the next trigger comes in before the time period set by Cx and Rx.

If the new trigger is very close to previous trigger, such as an occurrence during the discharge cycle, it will have no effect.

The minimum time for a trigger to be effective 2nd trigger,  $t_{tr}(\text{Min.})$ , depends on  $V_{CC}$  and Cx.

### (4) Reset operation

In normal operation, the  $\bar{CLR}$  input is held high. If  $\bar{CLR}$  is low, a trigger has no effect because the Q output is held low and the trigger control F/F is reset. Also,  $Q_P$  turns on and Cx is charged rapidly to  $V_{CC}$ .

This means if  $\bar{CLR}$  is set low, the IC goes into a wait state.

## MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Supply Voltage Range	V <sub>CC</sub>	-0.5~7	V
DC Input Voltage	V <sub>IN</sub>	-0.5~7	V
DC Output Voltage	V <sub>OUT</sub>	-0.5~V <sub>CC</sub> +0.5	V
Input Diode Current	I <sub>IK</sub>	-20	mA
Output Diode Current	I <sub>OK</sub>	±20	mA
DC Output Current	I <sub>OUT</sub>	±25	mA
DC V <sub>CC</sub> /Ground Current	I <sub>CC</sub>	±50	mA
Power Dissipation	P <sub>D</sub>	300 (SM8)	mW
		200 (US8)	
Storage Temperature	T <sub>stg</sub>	-65~150	°C
Lead Temperature (10 s)	T <sub>L</sub>	260	°C

## RECOMMENDED OPERATING CONDITIONS

CHARACTERISTIC	SYMBOL	RATING	UNIT
Supply Voltage	V <sub>CC</sub>	2~5.5	V
Input Voltage	V <sub>IN</sub>	0~5.5	V
Output Voltage	V <sub>OUT</sub>	0~V <sub>CC</sub>	V
Operating Temperature	T <sub>opr</sub>	-40~85	°C
Input Rise and Fall Time	dt/dv	0~100 (V <sub>CC</sub> = 3.3 ± 0.3V)	ns/V
		0~20 (V <sub>CC</sub> = 5 ± 0.5V)	
External Capacitor	C <sub>x</sub>	No Limitation*	F
External Resistor	R <sub>x</sub>	≥5k (V <sub>CC</sub> = 2.0V)*	Ω
		≥1k (V <sub>CC</sub> ≥ 3.0V)*	

- \* The maximum allowable values of C<sub>x</sub> and R<sub>x</sub> are a function of leakage of capacitor C<sub>x</sub>, the leakage of TC74VHC123A/221A, and leakage due to board layout and surface resistance.  
Susceptibility to externally induced noise signals may occur for R<sub>x</sub> > 1MΩ.

**DC ELECTRICAL CHARACTERISTICS**

CHARACTERISTIC		SYM-BOL	TEST CONDITION	V <sub>CC</sub> (V)	Ta = 25°C			Ta = -40~85°C		UNIT		
					MIN.	TYP.	MAX.	MIN.	MAX.			
Input Voltage	"H" Level	V <sub>IH</sub>		2.0	1.5	—	—	1.5	—	V		
				3.0~5.5	V <sub>CC</sub> × 0.7	—	—	V <sub>CC</sub> × 0.7	—			
	"L" Level	V <sub>IL</sub>		2.0	—	—	0.5	—	0.5			
				3.0~5.5	—	—	V <sub>CC</sub> × 0.3	—	V <sub>CC</sub> × 0.3			
Output Voltage	"H" Level	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -50 μA	2.0	1.9	2.0	—	1.9	—	V	
					3.0	2.9	3.0	—	2.9	—		
					4.5	4.4	4.5	—	4.4	—		
					3.0	2.58	—	—	2.48	—		
	"L" Level	V <sub>OL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 50 μA	4.5	3.94	—	—	3.80	—		
					I <sub>OL</sub> = 4mA	2.0	—	0	0.1	—		0.1
						3.0	—	0	0.1	—		0.1
						4.5	—	0	0.1	—		0.1
					I <sub>OL</sub> = 8mA	3.0	—	—	0.36	—		0.44
						4.5	—	—	0.36	—		0.44
Control Input Current		I <sub>IN</sub>	V <sub>IN</sub> = 5.5V or GND	0~5.5	—	—	±0.1	—	±1.0	μA		
Rx/Cx Terminal Off-State Current		I <sub>IN</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND	5.5	—	—	±0.25	—	±0.25	μA		
Quiescent Supply Current		I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND	5.5	—	—	2.0	—	20.0	μA		
				3.0	—	160	250	—	280			
		I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND Rx/Cx = 0.5V <sub>CC</sub>	4.5	—	380	500	—	650			
				5.5	—	560	750	—	975			

**TIMING REQUIREMENTS** (Input t<sub>r</sub> = t<sub>f</sub> = 3ns)

CHARACTERISTIC	SYMBOL	TEST CONDITION	V <sub>CC</sub> (V)	Ta = 25°C		Ta = -40~85°C	UNIT
				TYP.	LIMIT	LIMIT	
Minimum Pulse Width	t <sub>w</sub> (L)		3.3 ± 0.3	—	5.0	5.0	ns
	t <sub>w</sub> (H)		5.0 ± 0.5	—	5.0	5.0	
Minimum Clear Width (CLR)	t <sub>w</sub> (L)		3.3 ± 0.3	—	5.0	5.0	ns
			5.0 ± 0.5	—	5.0	5.0	
Minimum Retrigger Time	t <sub>rr</sub>	Rx = 1kΩ	3.3 ± 0.3	60	—	—	ns
		Cx = 100pF	5.0 ± 0.5	39	—	—	
		Rx = 1kΩ	3.3 ± 0.3	1.5	—	—	μs
		Cx = 0.01 μF	5.0 ± 0.5	1.2	—	—	

**AC ELECTRICAL CHARACTERISTICS (Input  $t_r = t_f = 3ns$ )**

PARAMETER	SYM-BOL	TEST CONDITION	Ta = 25°C			Ta = -40~85°C		UNIT		
			V <sub>CC</sub> (V)	CL (pF)	MIN.	TYP.	MAX.		MIN.	MAX.
Propagation Delay Time (A, B-Q)	t <sub>pLH</sub> t <sub>pHL</sub>		3.3 ± 0.3	15	—	13.4	20.6	1.0	24.0	ns
				50	—	15.9	24.1	1.0	27.5	
			5.0 ± 0.5	15	—	8.1	12.0	1.0	14.0	
				50	—	9.6	14.0	1.0	16.0	
Propagation Delay Time (CLR trigger-Q)	t <sub>pLH</sub> t <sub>pHL</sub>		3.3 ± 0.3	15	—	14.5	22.4	1.0	26.0	
				50	—	17.0	25.9	1.0	29.5	
			5.0 ± 0.5	15	—	8.7	12.9	1.0	15.0	
				50	—	10.2	14.9	1.0	17.0	
Propagation Delay Time (CLR-Q)	t <sub>pLH</sub> t <sub>pHL</sub>		3.3 ± 0.3	15	—	10.3	15.8	1.0	18.5	
				50	—	12.8	19.3	1.0	22.0	
			5.0 ± 0.5	15	—	6.3	9.4	1.0	11.0	
				50	—	7.8	11.4	1.0	13.0	
Output Pulse Width	t <sub>wOUT</sub>	Cx = 28pF Rx = 2kΩ	3.3 ± 0.3	50	—	160	240	—	300	μs
			5.0 ± 0.5		—	133	200	—	240	
		Cx = 0.01μF Rx = 10kΩ	3.3 ± 0.3	50	90	100	110	90	110	
			5.0 ± 0.5		90	100	110	90	110	
		Cx = 0.1μF Rx = 10kΩ	3.3 ± 0.3	50	0.9	1.0	1.1	0.9	1.1	ms
			5.0 ± 0.5		0.9	1.0	1.1	0.9	1.1	
Input Capacitance	C <sub>IN</sub>				4	10	—	10	pF	
Power Dissipation Capacitance	C <sub>pD</sub>	(Note 1)		—	73	—	—	—		

(Note 1) C<sub>pD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

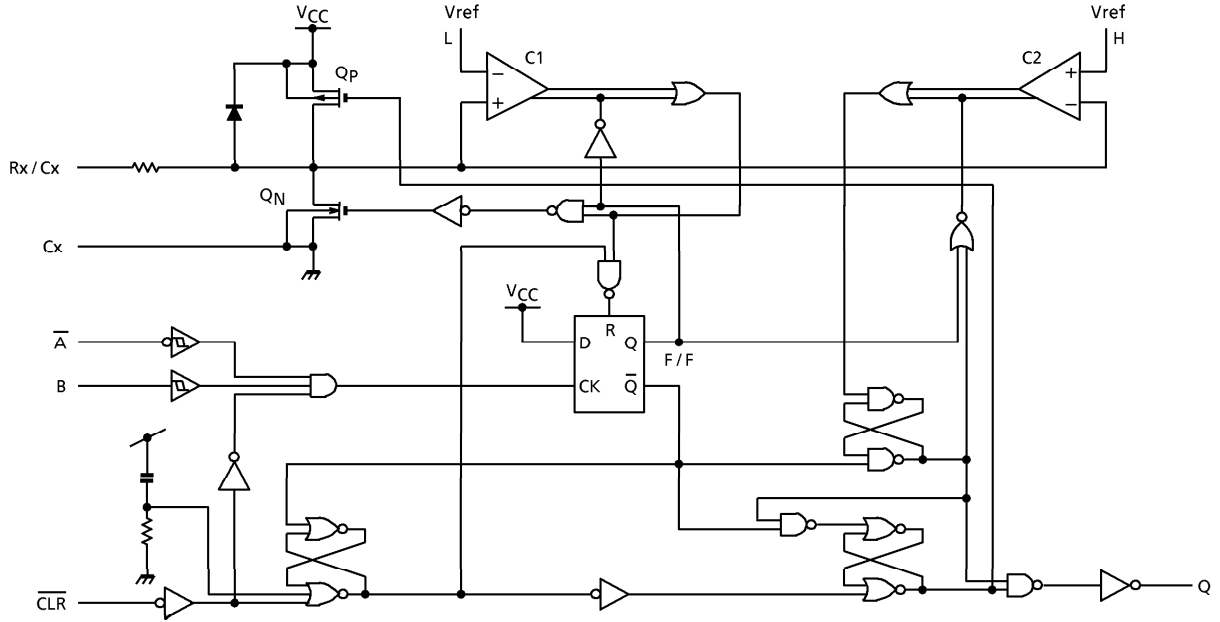
Average operating current can be obtained by the equation :

$$I_{CC(opr)} = C_{pD} \cdot V_{CC} \cdot f_{IN} + I_{CC'} \cdot \text{Duty} / 100 + I_{CC} / 2 \text{ (per circuit)}$$

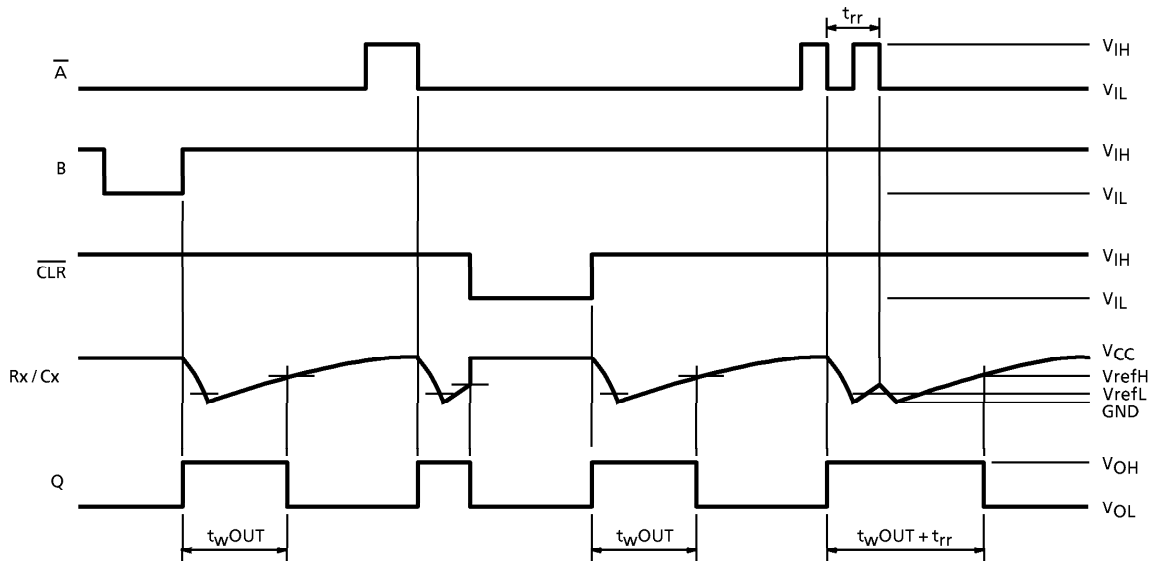
(I<sub>CC'</sub> : Active Supply Current)

(Duty : %)

**IEC LOGIC SYMBOL**



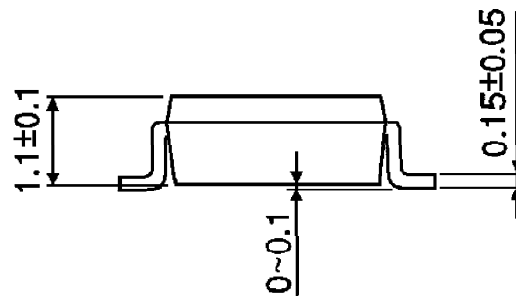
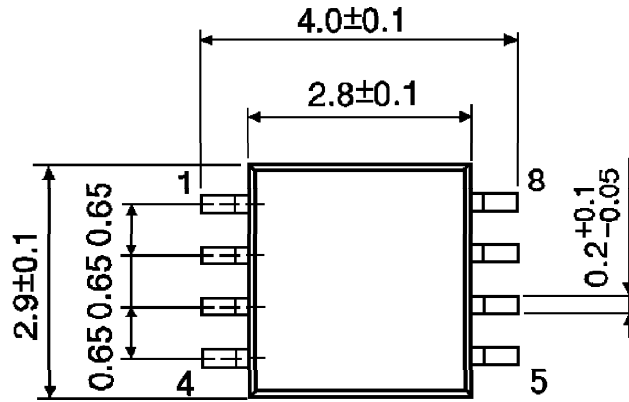
**Timing Chart**





PACKAGE DIMENSIONS  
SSOP8-P-0.65

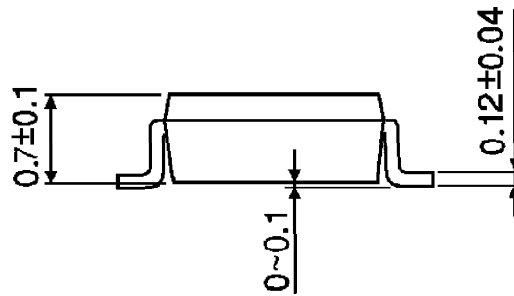
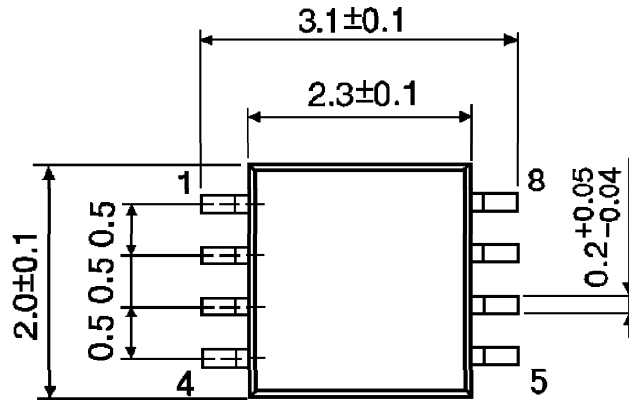
Unit : mm



Weight : 0.02g (Typ.)

PACKAGE DIMENSIONS  
SSOP8-P-0.50A

Unit : mm



Weight : 0.01g (Typ.)

**RESTRICTIONS ON PRODUCT USE**

000707EBA

- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property. In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc..
- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.). These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc.. Unintended Usage of TOSHIBA products listed in this document shall be made at the customer's own risk.
- The products described in this document are subject to the foreign exchange and foreign trade laws.
- The information contained herein is presented only as a guide for the applications of our products. No responsibility is assumed by TOSHIBA CORPORATION for any infringements of intellectual property or other rights of the third parties which may result from its use. No license is granted by implication or otherwise under any intellectual property or other rights of TOSHIBA CORPORATION or others.
- The information contained herein is subject to change without notice.